

Notice of References Cited	Application/Control No. 10/524,454		Applicant(s)/Patent Under Reexamination DALSTRA, JOOP	
	Examiner KEITH T. AZIZ		Art Unit 4122	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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NON-PATENT DOCUMENTS

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	U	Rantanen et al., "Use of the Near-Infrared Reflectance Method for Measurement of Moisture content during granulation", Pharmaceutical Development and Technology, Issue 5, 2000, pp. 209-217
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.